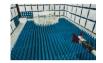


PCTEST

7185 Oakland Mills Road, Columbia, MD 21046 USA Tel. 410.290.6652 / Fax 410.290.6654 http://www.pctest.com



PART 22 MEASUREMENT REPORT

Applicant Name:
Samsung Electronics Co., Ltd.
129, Samsung-ro,
Yeongtong-gu, Suwon-si
Gyeonggi-do, 16677, Korea

Date of Testing:

1/08 - 2/19/2021

Test Site/Location:

PCTEST Lab. Columbia, MD, USA

Test Report Serial No.:

1M2101040001-16-R1.A3L

FCC ID: A3LSMA426U

Applicant Name: Samsung Electronics Co., Ltd.

Application Type: Certification **Model:** SM-A426U

Additional Model(s): SM-A426U1/DS, SM-S426DL, SM-A426U1

EUT Type: Portable Handset

FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)

FCC Rule Part: 22

Test Procedure(s): ANSI C63.26-2015, ANSI/TIA-603-E-2016, KDB 971168

D01 v03r01

Note: This revised Test Report (S/N: 1M2101040001-16-R1.A3L) supersedes and replaces the previously issued test report on the same subject device for the same type of testing as indicated. Please discard or destroy the previously issued test report(s) and dispose of it accordingly.

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

Randy Ortanez President

assembly of contents thereof, please contact INFO@PCTEST.COM.





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PART 22 MEASUREMENT REPORT



		Ty Fraguency	ERP		EIRP		Emission
Mode	Modulation	Tx Frequency Range [MHz]	Max. Power [W]	Max. Power [dBm]	Max. Power [W]	Max. Power [dBm]	Designator
GSM/GPRS	GMSK	824.2 - 848.8	0.805	29.06	1.321	31.21	244KGXW
EDGE	8-PSK	824.2 - 848.8	0.308	24.88	0.505	27.03	242KG7W
WCDMA	Spread Spectrum	826.4 - 846.6	0.068	18.30	0.111	20.45	4M16F9W
CDMA	Spread Spectrum	824.70 - 848.31	0.122	20.87	0.200	23.02	1M28F9W

			Ty Francisco	EF	₹P	EII	Emission	
Mode	Bandwidth	Modulation	Tx Frequency Range [MHz]	Max. Power [W]	Max. Power [dBm]	Max. Power [W]	Max. Power [dBm]	Designator
AFMUS (Done)	15MH= (Dand	QPSK	831.5 - 841.5	0.135	21.31	0.222	23.46	13M5G7D
	15MHz (Band 26 only)	16QAM	831.5 - 841.5	0.105	20.22	0.172	22.37	13M5W7D
	26 Offis)	64QAM	831.5 - 841.5	0.105	20.21	0.172	22.36	13M5W7D
		QPSK	829.0 - 844.0	0.139	21.43	0.228	23.58	9M01G7D
	10 MHz	16QAM	829.0 - 844.0	0.104	20.19	0.171	22.34	9M00W7D
		64QAM	829.0 - 844.0	0.109	20.39	0.179	22.54	8M98W7D
		QPSK	826.5 - 846.5	0.137	21.36	0.224	23.51	4M57G7D
LTE Band 26/5	5 MHz	16QAM	826.5 - 846.5	0.102	20.10	0.168	22.25	4M53W7D
		64QAM	826.5 - 846.5	0.107	20.29	0.175	22.44	4M53W7D
		QPSK	825.5 - 847.5	0.138	21.39	0.226	23.54	2M70G7D
	3 MHz	16QAM	825.5 - 847.5	0.101	20.06	0.166	22.21	2M71W7D
		64QAM	825.5 - 847.5	0.106	20.25	0.174	22.40	2M71W7D
		QPSK	824.7 - 848.3	0.133	21.24	0.218	23.39	1M10G7D
	1.4 MHz	16QAM	824.7 - 848.3	0.101	20.04	0.166	22.19	1M09W7D
		64QAM	824.7 - 848.3	0.104	20.19	0.171	22.34	1M09W7D
		π/2 BPSK	834.0 - 839.0	0.047	16.75	0.078	18.90	17M9G7D
		QPSK	834.0 - 839.0	0.052	17.12	0.085	19.27	19M1G7D
	20 MHz	16QAM	834.0 - 839.0	0.040	16.01	0.066	18.16	19M0W7D
		64QAM	834.0 - 839.0	0.029	14.62	0.048	16.77	19M0W7D
		256QAM	834.0 - 839.0	0.018	12.60	0.030	14.75	18M9W7D
		π/2 BPSK	831.5 - 841.5	0.049	16.88	0.080	19.03	13M5G7D
		QPSK	831.5 - 841.5	0.049	16.92	0.081	19.07	14M2G7D
	15 MHz	16QAM	831.5 - 841.5	0.043	16.32	0.070	18.47	14M2W7D
		64QAM	831.5 - 841.5	0.031	14.92	0.051	17.07	14M2W7D
NR Band n5		256QAM	831.5 - 841.5	0.018	12.67	0.030	14.82	14M1W7D
INK Dalla IIS		π/2 BPSK	829.0 - 844.0	0.048	16.82	0.079	18.97	8M99G7D
		QPSK	829.0 - 844.0	0.054	17.31	0.088	19.46	9M34G7D
	10 MHz	16QAM	829.0 - 844.0	0.044	16.48	0.073	18.63	9M34W7D
		64QAM	829.0 - 844.0	0.031	14.97	0.051	17.12	9M36W7D
		256QAM	829.0 - 844.0	0.019	12.89	0.032	15.04	9M34W7D
		π/2 BPSK	826.5 - 846.5	0.050	16.98	0.082	19.13	4M51G7D
		QPSK	826.5 - 846.5	0.052	17.17	0.085	19.32	4M50G7D
	5 MHz	16QAM	826.5 - 846.5	0.043	16.33	0.070	18.48	4M54W7D
		64QAM	826.5 - 846.5	0.031	14.97	0.051	17.12	4M52W7D
		256QAM	826.5 - 846.5	0.019	12.80	0.031	14.95	4M50W7D

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada.

1.2 PCTEST Test Location

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The measurement facility is compliant with the test site requirements specified in ANSI C63.4-2014.

1.3 Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.

- PCTEST is an ISO 17025-2017 accredited test facility under the American Association for Laboratory Accreditation (A2LA) with Certificate number 2041.01 for Specific Absorption Rate (SAR), Hearing Aid Compatibility (HAC) testing, where applicable, and Electromagnetic Compatibility (EMC) testing for FCC and Innovation, Science, and Economic Development Canada rules.
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC 17065-2012 by A2LA (Certificate number 2041.03) in all scopes of FCC Rules and ISED Standards (RSS).
- PCTEST facility is a registered (2451B) test laboratory with the site description on file with ISED.

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PRODUCT INFORMATION 2.0

2.1 **Equipment Description**

The Equipment Under Test (EUT) is the Samsung Portable Handset FCC ID: A3LSMA426U. The test data contained in this report pertains only to the emissions due to the EUT's licensed transmitters that operate under the provisions of Part 22.

Test Device Serial No.: 01719, 01685, 01800, 13623, 01776, 01875, 01792, 13276,01693

2.2 **Device Capabilities**

This device contains the following capabilities:

800/850/1900 CDMA/EvDO Rev0/A, 1x Advanced (BC0, BC1, BC10), 850/1900 GSM/GPRS/EDGE, 850/1700/1900 WCDMA/HSPA, Multi-band LTE, 5G NR (n5, n71, n41, n66, n2, n25, n77, n260, n261), 802.11b/g/n WLAN, 802.11a/n/ac UNII (5GHz), Bluetooth (1x, EDR, LE), NFC

2.3 **Test Configuration**

The EUT was tested per the guidance of ANSI/TIA-603-E-2016 and KDB 971168 D01 v03r01. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

EMI Suppression Device(s)/Modifications 2.4

No EMI suppression device(s) were added and no modifications were made during testing.

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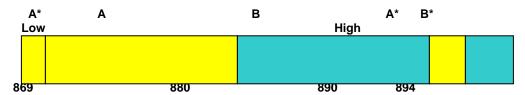
3.0 DESCRIPTION OF TESTS

3.1 Evaluation Procedure

The measurement procedures described in the "Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards" (ANSI/TIA-603-E-2016) and "Measurement Guidance for Certification of Licensed Digital Transmitters" (KDB 971168 D01 v03r01) were used in the measurement of the EUT.

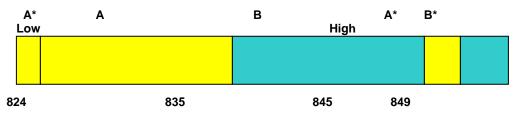
Deviation from Measurement Procedure......None

3.2 Cellular - Base Frequency Blocks



BLOCK 1: 869 – 880 MHz (A* Low + A) BLOCK 3: 890 – 891.5 MHz (A* High) BLOCK 2: 880 – 890 MHz (B) BLOCK 4: 891.5 – 894 MHz (B*)

3.3 Cellular - Mobile Frequency Blocks



BLOCK 1: 824 – 835 MHz (A* Low + A) BLOCK 3: 845 – 846.5 MHz (A* High) BLOCK 2: 835 – 845 MHz (B) BLOCK 4: 846.5 – 849 MHz (B*)

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3.4 Radiated Power and Radiated Spurious Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Figure 5.7 of Clause 5 in ANSI C63.4-2014. Absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz. For measurements below 1GHz, the absorbers are removed. A raised turntable is used for radiated measurement. The turn table is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm tall test table made of Styrodur is placed on top of the turn table. A Styrodur pedestal is placed on top of the test table to bring the total table height to 1.5m.

The equipment under test was transmitting while connected to its integral antenna and is placed on a turntable 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer.

For radiated power measurements, substitution method is used per the guidance of ANSI/TIA-603-E-2016. A half-wave dipole is substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

 $P_{d \ [dBm]} = P_{g \ [dBm]} - cable \ loss \ [_{dB]} + antenna \ gain \ [_{dBd/dBi]};$ where P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_{g \ [dBm]} - cable \ loss \ [_{dB]}$.

For radiated spurious emissions measurements and calculations, conversion method is used per the formulas in KDB 971168 Section 5.8.4. Field Strength (EIRP) is calculated using the following formulas:

 $E_{[dB\mu V/m]} = Measured$ amplitude level $_{[dBm]} + 107 + Cable Loss_{[dB]} + Antenna Factor_{[dB/m]}$ And $EIRP_{[dBm]} = E_{[dB\mu V/m]} + 20logD - 104.8$; where D is the measurement distance in meters.

All radiated measurements are performed in a chamber that meets the site requirements per ANSI C63.4-2014. Additionally, radiated emissions below 30MHz are also validated on an Open Area Test Site to assert correlation with the chamber measurements per the requirements of KDB 474788 D01.

Radiated power and radiated spurious emission levels are investigated with the receive antenna horizontally and vertically polarized per ANSI/TIA-603-E-2016.

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MEASUREMENT UNCERTAINTY 4.0

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of k = 2 to indicate a 95% level of confidence. The measurement uncertainty shown below meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty (±dB)
Conducted Bench Top Measurements	1.13
Radiated Disturbance (<1GHz)	4.98
Radiated Disturbance (>1GHz)	5.07
Radiated Disturbance (>18GHz)	5.09

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TEST EQUIPMENT CALIBRATION DATA 5.0

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST). Measurements antennas used during testing were calibrated in accordance to the requirements of ANSI C63.5-2017.

117.						
Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	LTx2	Licensed Transmitter Cable Set	4/9/2020	Annual	4/9/2021	LTx2
-	LTx4	Licensed Transmitter Cable Set	7/9/2020	Annual	7/9/2021	LTx4
-	LTx5	Licensed Transmitter Cable Set	4/9/2020	Annual	4/6/2021	LTx5
Agilent	N9020A	MXA Signal Analyzer	8/4/2020	Annual	8/4/2021	US46470561
Agilent	N9030A	PXA Signal Analyzer (44GHz)	7/17/2020	Annual	7/17/2021	MY52350166
Agilent	E5515C	Wireless Communications Test Set		N/A		GB45360985
Anritsu	MT8821C	Radio Communication Analyzer		N/A		6201381794
Anritsu	MT8821C	Radio Communication Analyzer		N/A		6200901190
Com-Power	AL-130	9kHz - 30MHz Loop Antenna	10/10/2019	Biennial	10/10/2021	121034
Emco	3115	Horn Antenna (1-18GHz)	6/18/2020	Biennial	6/18/2022	9704-5182
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	3/12/2020	Biennial	3/12/2022	128337
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	2/22/2019	Biennial	2/22/2021	128338
Mini Circuits	TVA-11-422	RF Power Amp		N/A		
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator		N/A		11208010032
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator		N/A		11403100002
Rohde & Schwarz	CMU200	Base Station Simulator		N/A		836371/0079
Rohde & Schwarz	CMU200	Base Station Simulator		N/A		836536/0005
Rohde & Schwarz	CMW500	Radio Communication Tester		N/A		100976
Rohde & Schwarz	CMW500	Radio Communication Tester		N/A		112347
Rohde & Schwarz	ESU26	EMI Test Receiver (26.5GHz)	7/15/2020	Annual	7/15/2021	100342
Rohde & Schwarz	SFUNIT-Rx	Shielded Filter Unit	2/10/2020	Annual	2/10/2021	102134
Rohde & Schwarz	SFUNIT-Rx	Shielded Filter Unit	2/21/2020	Annual	2/21/2021	102133
Sunol	DRH-118	Horn Antenna (1-18GHz)	10/3/2019	Biennial	10/3/2021	A050307
Sunol	DRH-118	Horn Antenna (1-18 GHz)	8/27/2019	Biennial	8/27/2021	A042511
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	7/27/2020	Biennial	7/27/2022	A051107

Table 5-1. Test Equipment

Notes:

- 1. For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date.
- 2. Equipment with a calibration date of "N/A" shown in this list was not used to make direct calibrated measurements.

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6.0 SAMPLE CALCULATIONS

GSM Emission Designator

Emission Designator = 250KGXW

GSM BW = 250 kHzG = Phase Modulation X = Cases not otherwise covered

W = Combination (Audio/Data)

EDGE Emission Designator

Emission Designator = 250KG7W

EDGE BW = 250 kHz G = Phase Modulation 7 = Quantized/Digital Info W = Combination (Audio/Data)

CDMA Emission Designator

Emission Designator = 1M25F9W

CDMA BW = 1.25 MHz F = Frequency Modulation 9 = Composite Digital Info W = Combination (Audio/Data)

WCDMA Emission Designator

Emission Designator = 4M16F9W

WCDMA BW = 4.16 MHz F = Frequency Modulation 9 = Composite Digital Info W = Combination (Audio/Data)

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz
G = Phase Modulation
7 = Quantized/Digital Info
D = Data transmission, telemetry, telecommand

QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz W = Amplitude/Angle Modulated 7 = Quantized/Digital Info D = Data transmission, telemetry, telecommand

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Spurious Radiated Emission

assembly of contents thereof, please contact INFO@PCTEST.COM.

Example: Spurious emission at 3700.40 MHz

The receive spectrum analyzer reading at 3 meters with the EUT on the turntable was -81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of -81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 3700.40 MHz. So 6.1 dB is added to the signal generator reading of -30.9 dBm yielding -24.80 dBm. The fundamental EIRP was 25.50 dBm so this harmonic was 25.50 dBm -(-24.80) = 50.3 dBc.

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7.0 TEST RESULTS

7.1 Summary

Company Name: <u>Samsung Electronics Co., Ltd.</u>

FCC ID: <u>A3LSMA426U</u>

FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)

Mode(s): NR/GSM/GPRS/WCDMA/CDMA/LTE

Test Condition	Test Description	FCC Part Section(s)	RSS Section(s)	Test Limit	Test Result	Reference
0	Occupied Bandwidth	2.1049	RSS-Gen(6.7)	N/A	PASS	Section 7.2
CONDUCTED	Conducted Band Edge / Spurious Emissions	2.1051, 22.917(a)	RSS-132(5.5)	> 43 + 10log10(P[Watts]) at Band Edge and for all out-of- band emissions	PASS	Sections 7.3, 7.4
ONDI	Transmitter Conducted Output Power	2.1046	RSS-132(5.4)	N/A	PASS	See RF Exposure Report
_	Frequency Stability	2.1055, 22.355	RSS-132(5.3)	Fundamental emissions stay within authorized frequency block	PASS	Section 7.8
SADIATED	Effective Radiated Power / Equivalent Is atropic Radiated Power	22. 913(a)(5)	R SS-132(5.4)	< 7 W atts max. ERP	PASS	Section 7.6
RADI	Radiated Spurious Emissions	2.1053, 22.917(a)	R SS-132(5.5)	> 43 + 10 log10 (P[W atts]) for all out-of-band emissions	PASS	Section 7.7

Table 7-1. Summary of Test Results

Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
- 4) All conducted emissions measurements are performed with automated test software to capture the corresponding plots necessary to show compliance. The measurement software utilized is PCTEST 2G/3G Automation Version 4.5, LTE Automation Version 5.3.

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7.2 Occupied Bandwidth

Test Overview

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Procedure Used

KDB 971168 D01 v03r01 - Section 4.2

Test Settings

- 1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
- 2. RBW = 1 5% of the expected OBW
- 3. VBW \geq 3 x RBW
- 4. Detector = Peak
- 5. Trace mode = max hold
- 6. Sweep = auto couple
- 7. The trace was allowed to stabilize
- 8. If necessary, steps 2-7 were repeated after changing the RBW such that it would be within
 - 1 5% of the 99% occupied bandwidth observed in Step 7

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.



Figure 7-1. Test Instrument & Measurement Setup

Test Notes

None.

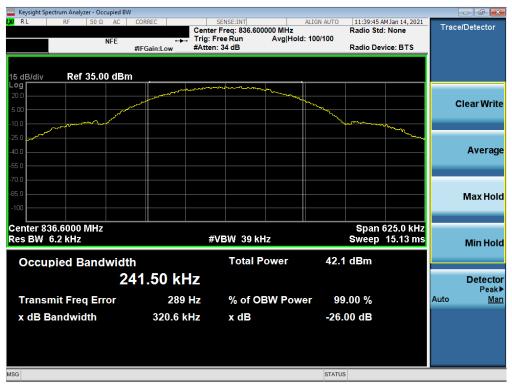
FCC ID: A3LSMA426U	Protest*	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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GPRS Cell



Plot 7-1. Occupied Bandwidth Plot (GPRS, Ch. 190)



Plot 7-2. Occupied Bandwidth Plot (EDGE, Ch. 190)

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WCDMA Cell



Plot 7-3. Occupied Bandwidth Plot (WCDMA, Ch. 4183)

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CDMA Cell

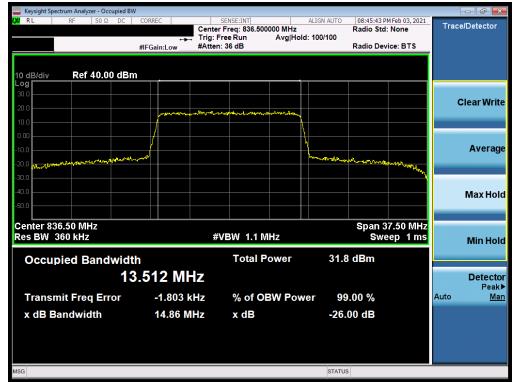


Plot 7-4. Occupied Bandwidth Plot (CDMA, Ch. 384)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager	
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LTE Band 26/5



Plot 7-5. Occupied Bandwidth Plot (LTE Band 26/5 - 15MHz QPSK - Full RB Configuration)



Plot 7-6. Occupied Bandwidth Plot (LTE Band 26/5 - 15MHz 16-QAM - Full RB Configuration)

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Plot 7-7. Occupied Bandwidth Plot (LTE Band 26/5 - 15MHz 64-QAM - Full RB Configuration)



Plot 7-8. Occupied Bandwidth Plot (LTE Band 26/5 - 10MHz QPSK - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-9. Occupied Bandwidth Plot (LTE Band 26/5 - 10MHz 16-QAM - Full RB Configuration)



Plot 7-10. Occupied Bandwidth Plot (LTE Band 26/5 - 10MHz 64-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-11. Occupied Bandwidth Plot (LTE Band 26/5 - 5MHz QPSK - Full RB Configuration)



Plot 7-12. Occupied Bandwidth Plot (LTE Band 26/5 - 5MHz 16-QAM - Full RB Configuration)

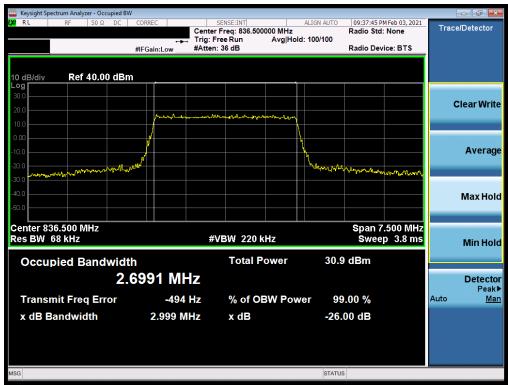
FCC ID: A3LSMA426U	Proud to be port of @ element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
Test Report S/N:	Test Dates:	EUT Type:		Dogo 20 of 112
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Plot 7-13. Occupied Bandwidth Plot (LTE Band 26/5 - 5MHz 64-QAM - Full RB Configuration)



Plot 7-14. Occupied Bandwidth Plot (LTE Band 26/5 - 3MHz QPSK - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-15. Occupied Bandwidth Plot (LTE Band 26/5 - 3MHz 16-QAM - Full RB Configuration)



Plot 7-16. Occupied Bandwidth Plot (LTE Band 26/5 - 3MHz 64-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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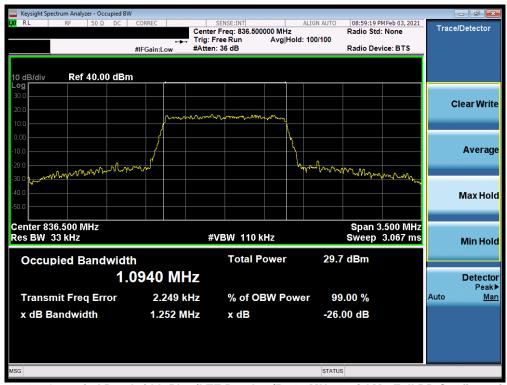
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Plot 7-17. Occupied Bandwidth Plot (LTE Band 26/5 - 1.4MHz QPSK - Full RB Configuration)



Plot 7-18. Occupied Bandwidth Plot (LTE Band 26/5 - 1.4MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	PCTEST* Proud to be port of @ element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-19. Occupied Bandwidth Plot (LTE Band 26/5 - 1.4MHz 64-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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NR Band n5



Plot 7-20. Occupied Bandwidth Plot (NR Band n5 - 20MHz π/2 BPSK - Full RB Configuration)



Plot 7-21. Occupied Bandwidth Plot (NR Band n5 - 20MHz QPSK - Full RB Configuration)

FCC ID: A3LSMA426U	PCTEST* Proud to be part of @ element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
Test Report S/N:	Test Dates:	EUT Type:		Dogo 25 of 112
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Plot 7-22. Occupied Bandwidth Plot (NR Band n5 - 20MHz 16-QAM - Full RB Configuration)



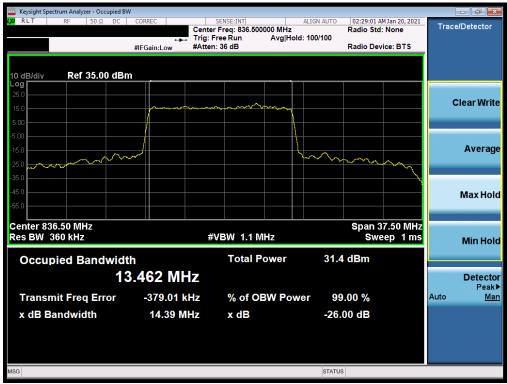
Plot 7-23. Occupied Bandwidth Plot (NR Band n5 - 20MHz 64-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-24. Occupied Bandwidth Plot (NR Band n5 - 20MHz 256-QAM - Full RB Configuration)



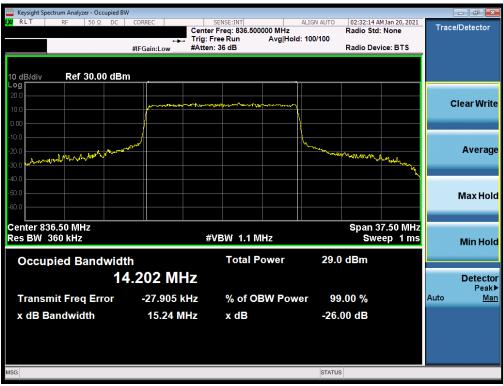
Plot 7-25. Occupied Bandwidth Plot (NR Band n5 - 15MHz π/2 BPSK - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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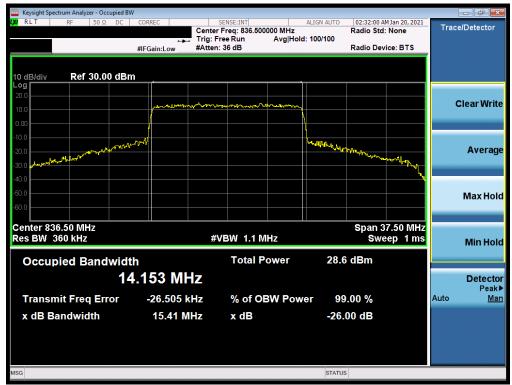
Plot 7-26. Occupied Bandwidth Plot (NR Band n5 - 15MHz QPSK - Full RB Configuration)



Plot 7-27. Occupied Bandwidth Plot (NR Band n5 - 15MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-28. Occupied Bandwidth Plot (NR Band n5 - 15MHz 64-QAM - Full RB Configuration)



Plot 7-29. Occupied Bandwidth Plot (NR Band n5 - 15MHz 256-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-30. Occupied Bandwidth Plot (NR Band n5 - 10MHz π/2 BPSK - Full RB Configuration)



Plot 7-31. Occupied Bandwidth Plot (NR Band n5 - 10MHz QPSK - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-32. Occupied Bandwidth Plot (NR Band n5 - 10MHz 16-QAM - Full RB Configuration)



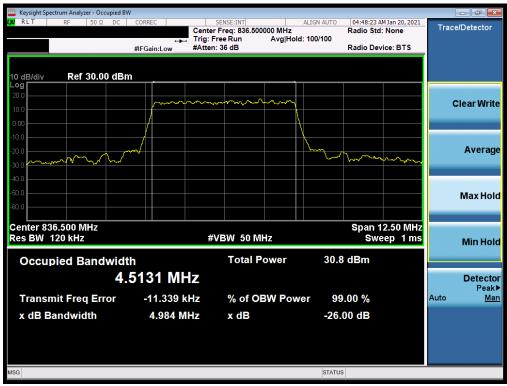
Plot 7-33. Occupied Bandwidth Plot (NR Band n5 - 10MHz 64-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager	
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Plot 7-34. Occupied Bandwidth Plot (NR Band n5 - 10MHz 256-QAM - Full RB Configuration)



Plot 7-35. Occupied Bandwidth Plot (NR Band n5 - 5MHz π/2 BPSK - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager	
Test Report S/N:	Test Dates:	EUT Type:		Page 32 of 113	
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Plot 7-36. Occupied Bandwidth Plot (NR Band n5 - 5MHz QPSK - Full RB Configuration)



Plot 7-37. Occupied Bandwidth Plot (NR Band n5 - 5MHz 16-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager	
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Plot 7-38. Occupied Bandwidth Plot (NR Band n5 - 5MHz 64-QAM - Full RB Configuration)



Plot 7-39. Occupied Bandwidth Plot (NR Band n5 - 5MHz 256-QAM - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager	
Test Report S/N:	Test Dates:	EUT Type:		Page 34 of 113	
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7.3 Spurious and Harmonic Emissions at Antenna Terminal

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is 43 + 10 $log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03r01 - Section 6.0

Test Settings

- 1. Start frequency was set to 30MHz and stop frequency was set to 10GHz (separated into at least two plots per channel)
- 2. Detector = RMS
- 3. Trace mode = trace average for continuous emissions, max hold for pulse emissions
- 4. Sweep time = auto couple
- The trace was allowed to stabilize
- 6. Please see test notes below for RBW and VBW settings

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.



Figure 7-2. Test Instrument & Measurement Setup

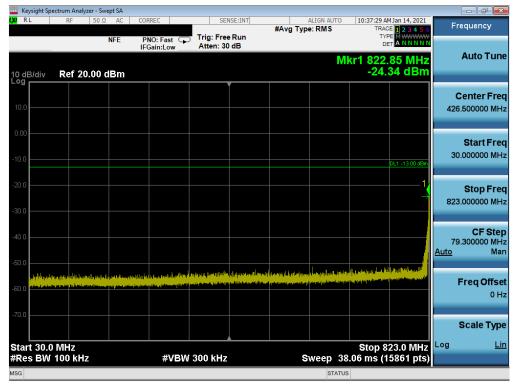
Test Notes

- 1. Per Part 22 and RSS-132, compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth 100 kHz or greater for measurements below 1GHz. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.
- 2. For NR operation, all subcarrier spacings (SCS) and transmission schemes (e.g. CP-OFDM and DFT-s-OFDM) were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

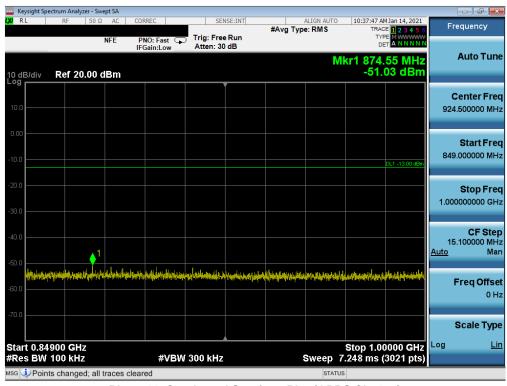
FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager	
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GSM/GPRS Cell



Plot 7-40. Conducted Spurious Plot (GPRS Ch. 128)



Plot 7-41. Conducted Spurious Plot (GPRS Ch. 128)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager	
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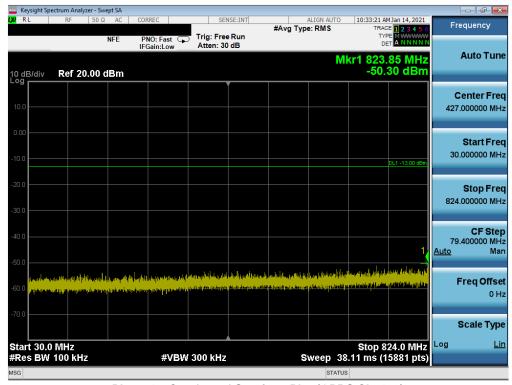
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Plot 7-42. Conducted Spurious Plot (GPRS Ch. 128)



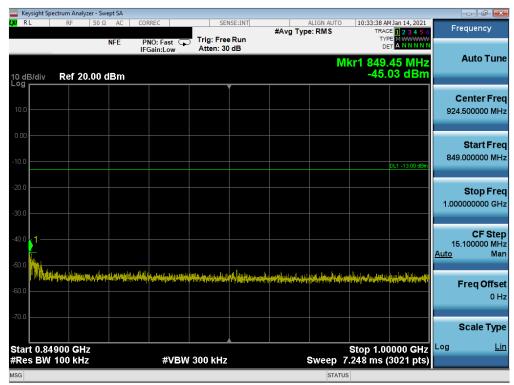
Plot 7-43. Conducted Spurious Plot (GPRS Ch. 190)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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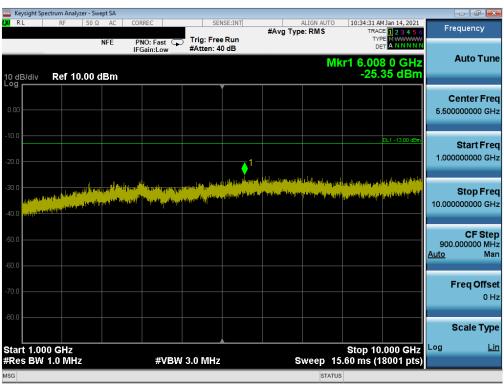
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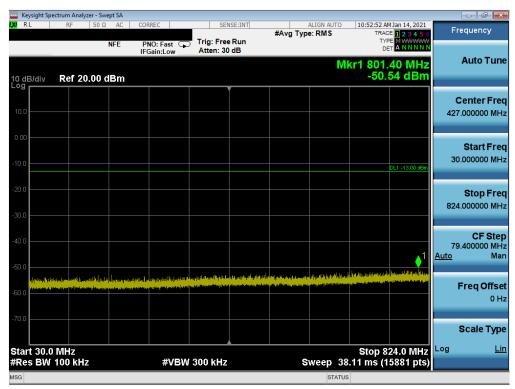
Plot 7-44. Conducted Spurious Plot (GPRS Ch. 190)



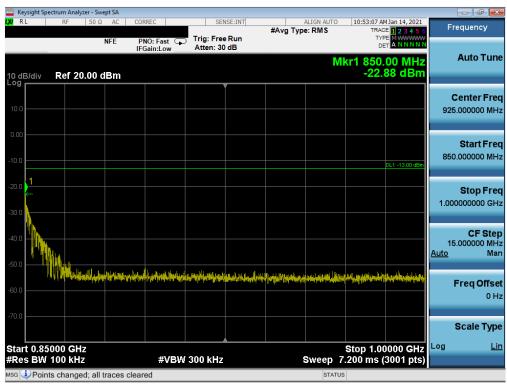
Plot 7-45. Conducted Spurious Plot (GPRS Ch. 190)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-46. Conducted Spurious Plot (GPRS Ch. 251)



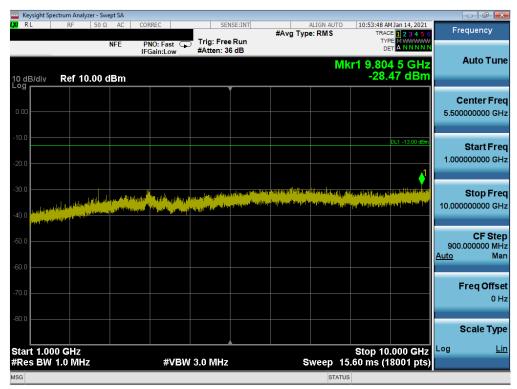
Plot 7-47. Conducted Spurious Plot (GPRS Ch. 251)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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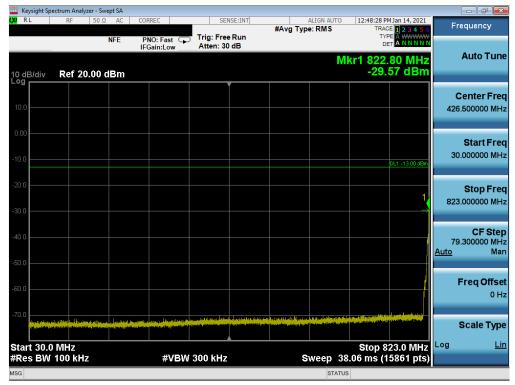
Plot 7-48. Conducted Spurious Plot (GPRS Ch. 251)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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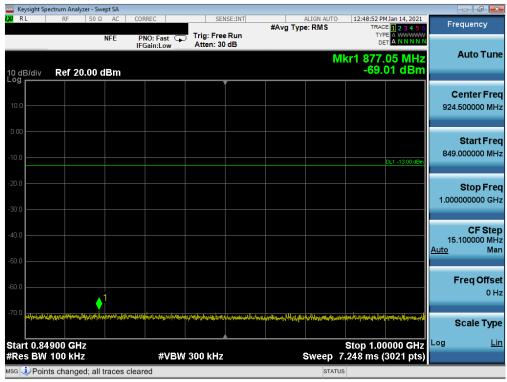
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WCDMA Cell



Plot 7-49. Conducted Spurious Plot (WCDMA Ch. 4132)

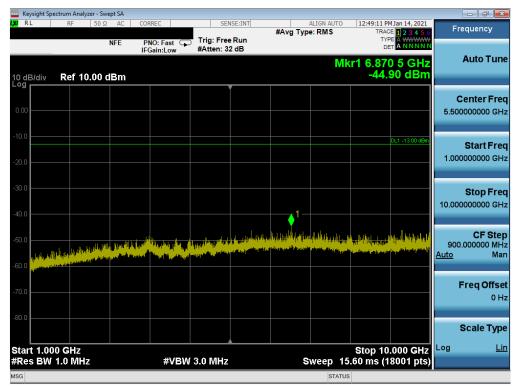


Plot 7-50. Conducted Spurious Plot (WCDMA Ch. 4132)

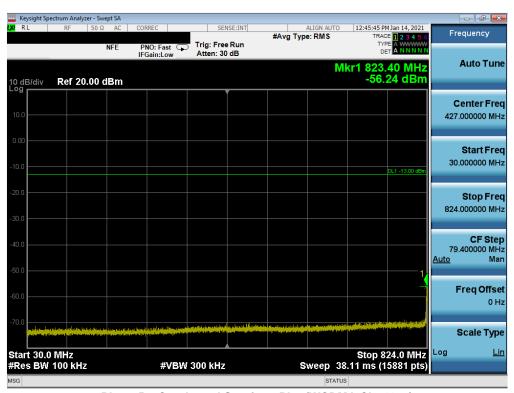
FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-51. Conducted Spurious Plot (WCDMA Ch. 4132)



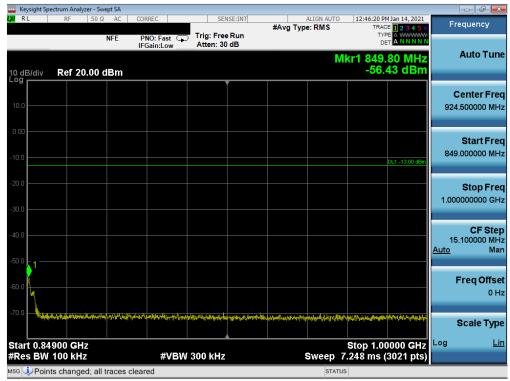
Plot 7-52. Conducted Spurious Plot (WCDMA Ch. 4183)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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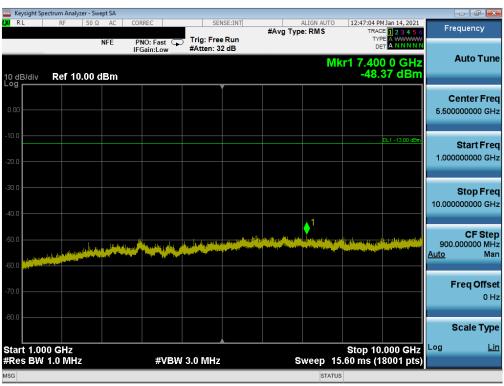
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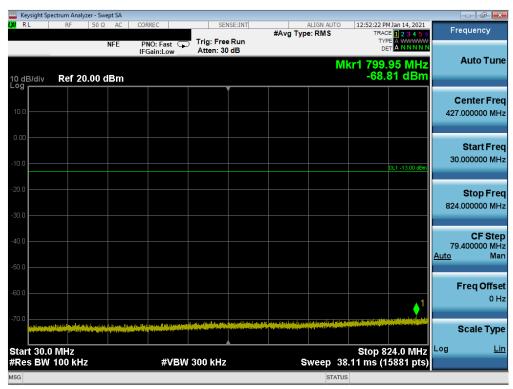
Plot 7-53. Conducted Spurious Plot (WCDMA Ch. 4183)



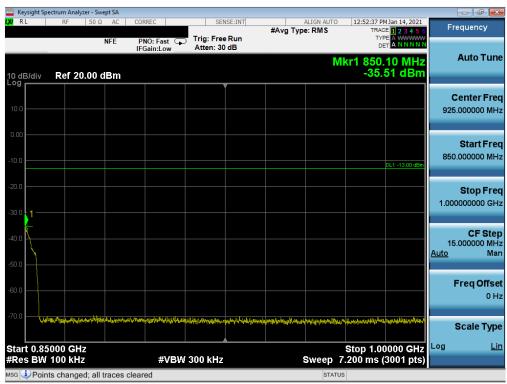
Plot 7-54. Conducted Spurious Plot (WCDMA Ch. 4183)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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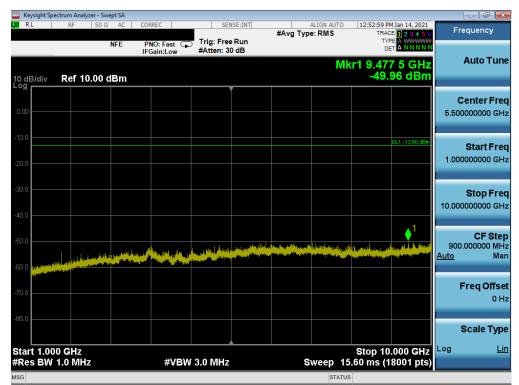
Plot 7-55. Conducted Spurious Plot (WCDMA Ch. 4233)



Plot 7-56. Conducted Spurious Plot (WCDMA Ch. 4233)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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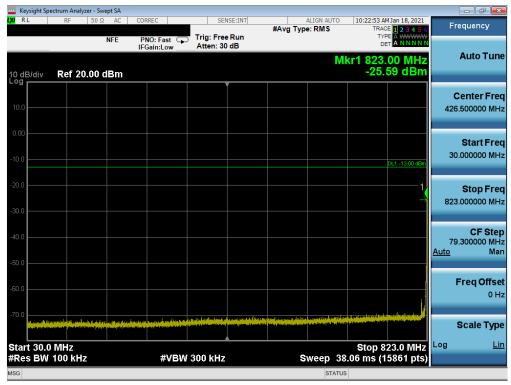
Plot 7-57. Conducted Spurious Plot (WCDMA Ch. 4233)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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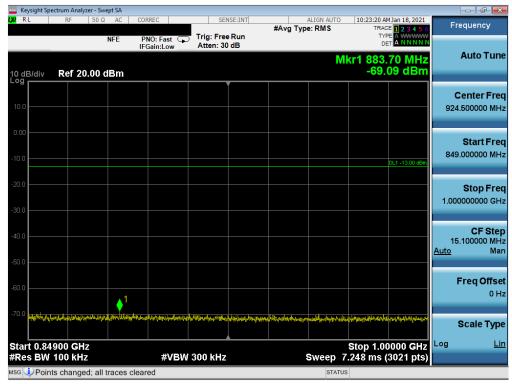
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CDMA Cell



Plot 7-58. Conducted Spurious Plot (CDMA Ch. 1013)

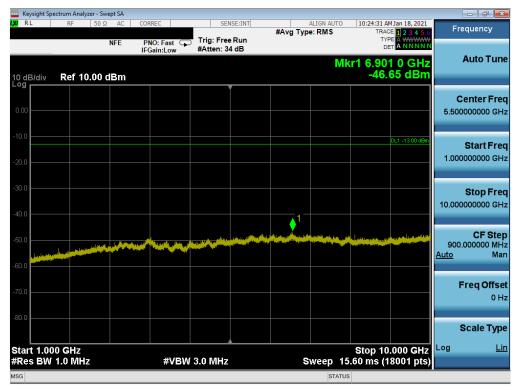


Plot 7-59. Conducted Spurious Plot (CDMA Ch. 1013)

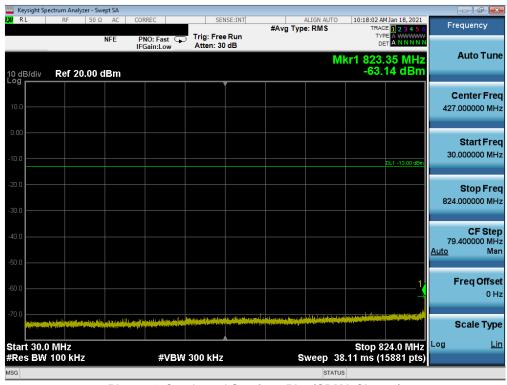
FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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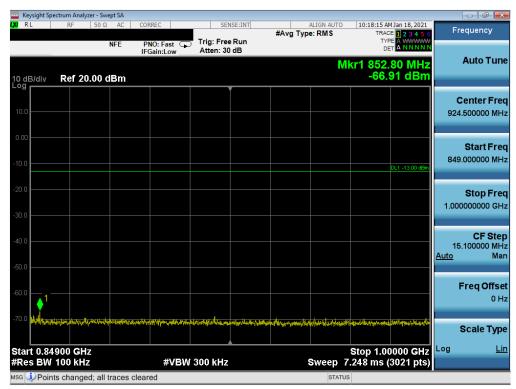
Plot 7-60. Conducted Spurious Plot (CDMA Ch. 1013)



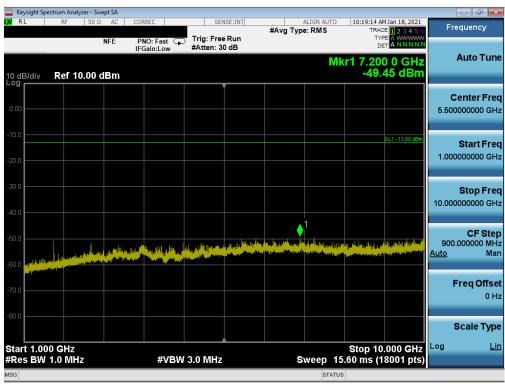
Plot 7-61. Conducted Spurious Plot (CDMA Ch. 384)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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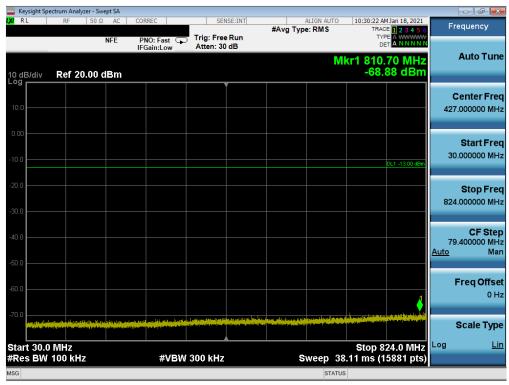
Plot 7-62. Conducted Spurious Plot (CDMA Ch. 384)



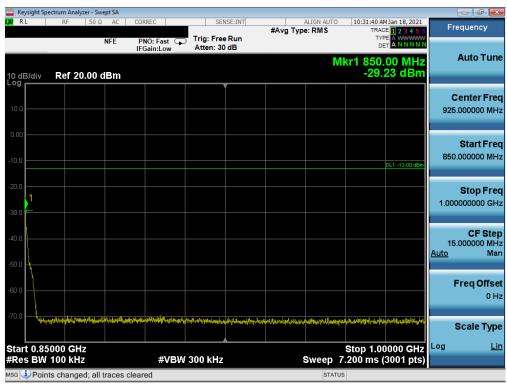
Plot 7-63. Conducted Spurious Plot (CDMA Ch. 384)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-64. Conducted Spurious Plot (CDMA Ch. 777)



Plot 7-65. Conducted Spurious Plot (CDMA Ch. 777)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-66. Conducted Spurious Plot (CDMA Ch. 777)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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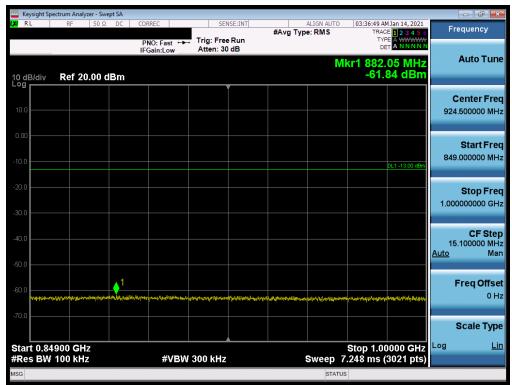
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LTE Band 26/5



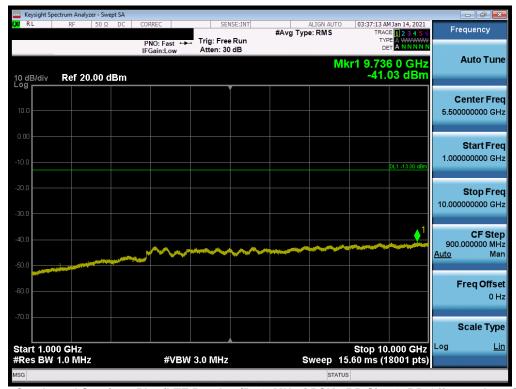
Plot 7-67. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)



Plot 7-68. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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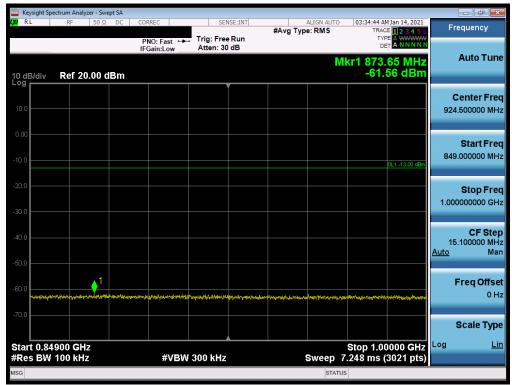
Plot 7-69. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)



Plot 7-70. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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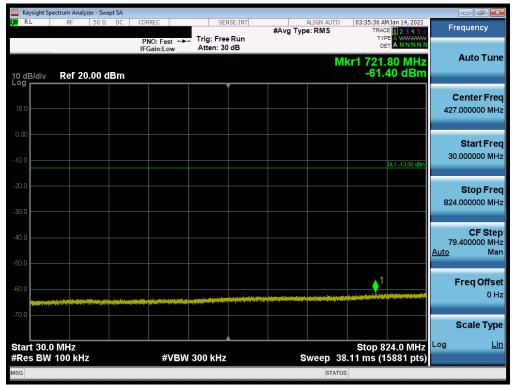
Plot 7-71. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)



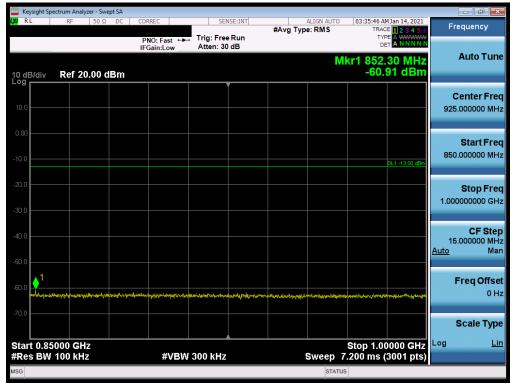
Plot 7-72. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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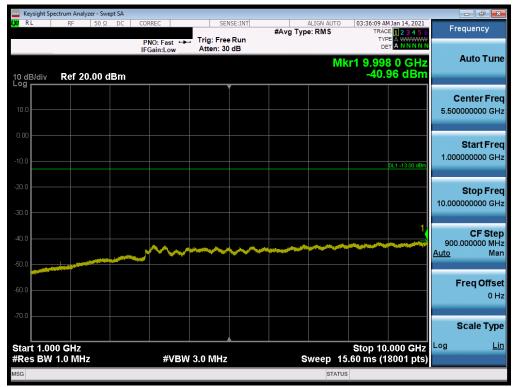
Plot 7-73. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-74. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-75. Conducted Spurious Plot (LTE Band 26/5 - 10MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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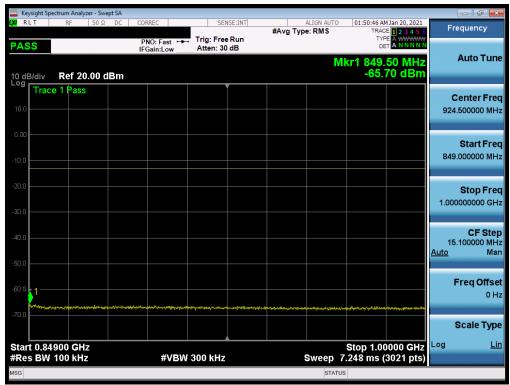
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NR Band n5



Plot 7-76. Conducted Spurious Plot (NR Band n5 - 20.0MHz - RB Size 1, RB Offset 0 - Low Channel)



Plot 7-77. Conducted Spurious Plot (NR Band n5 - 20.0MHz- RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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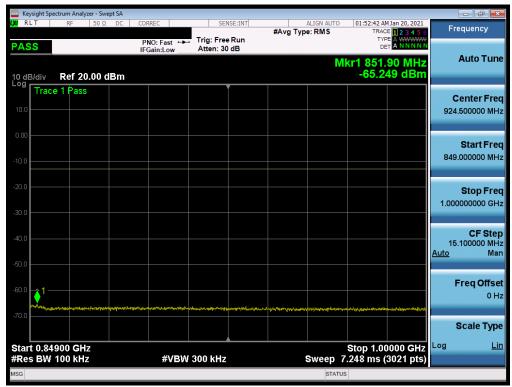
Plot 7-78. Conducted Spurious Plot (NR Band n5 - 20.0MHz - RB Size 1, RB Offset 0 - Low Channel)



Plot 7-79. Conducted Spurious Plot (NR Band n5 - 20.0MHz - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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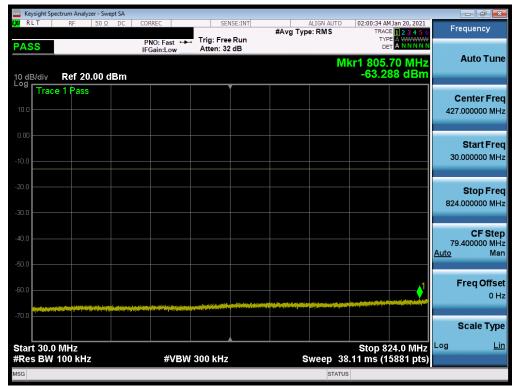
Plot 7-80. Conducted Spurious Plot (NR Band n5 - 20.0MHz - RB Size 1, RB Offset 0 - Mid Channel)



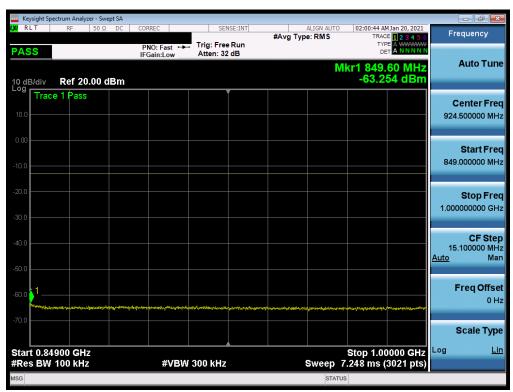
Plot 7-81. Conducted Spurious Plot (NR Band n5 - 20.0MHz - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-82. Conducted Spurious Plot (NR Band n5 - 20.0MHz - RB Size 1, RB Offset 0 - High Channel)



Plot 7-83. Conducted Spurious Plot (NR Band n5 - 20.0MHz - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-84. Conducted Spurious Plot (NR Band n5 - 20.0MHz - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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7.4 Band Edge Emissions at Antenna Terminal

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + 10 \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03r01 - Section 6.0

Test Settings

- 1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
- 2. Span was set large enough so as to capture all out of band emissions near the band edge
- 3. RBW > 1% of the emission bandwidth
- 4. $VBW > 3 \times RBW$
- 5. Detector = RMS
- 6. Number of sweep points ≥ 2 x Span/RBW
- 7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
- 8. Sweep time = auto couple
- 9. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.



Figure 7-3. Test Instrument & Measurement Setup

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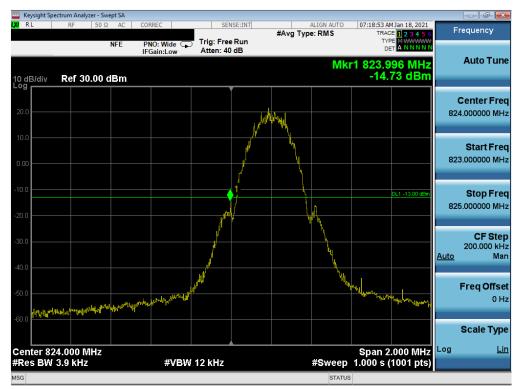
Test Notes

- 1. Per 22.917(b) and RSS-132(5.5), in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.
- 2. For NR operation, all subcarrier spacings (SCS) and transmission schemes (e.g. CP-OFDM and DFT-s-OFDM) were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

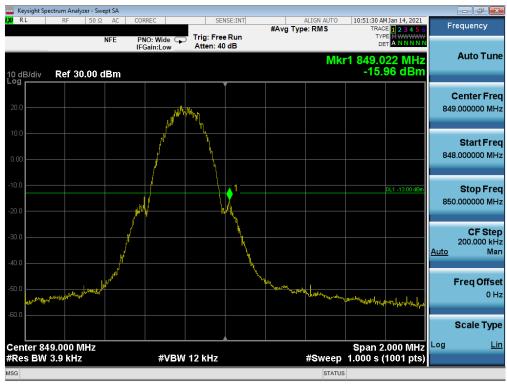
FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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GSM/GPRS Cell



Plot 7-85. Lower Band Edge Plot (GSM Cell - Ch. 128)

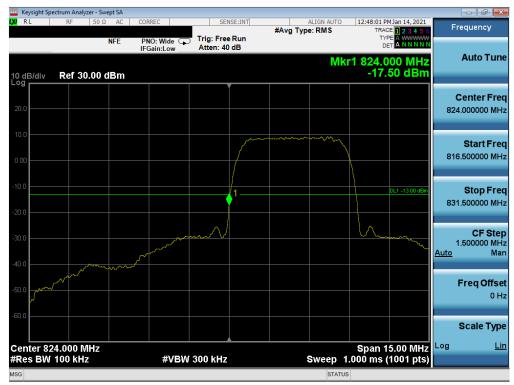


Plot 7-86. Upper Band Edge Plot (GPRS Cell - Ch. 251)

FCC ID: A3LSMA426U	PCTEST* Proud to be port of ® element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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WCDMA Cell



Plot 7-87. Lower Band Edge Plot (WCDMA Cell - Ch. 4132)



Plot 7-88. Upper Band Edge Plot (WCDMA Cell - Ch. 4233)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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CDMA Cell



Plot 7-89. Lower Band Edge Plot (CDMA Cell - Ch. 1013)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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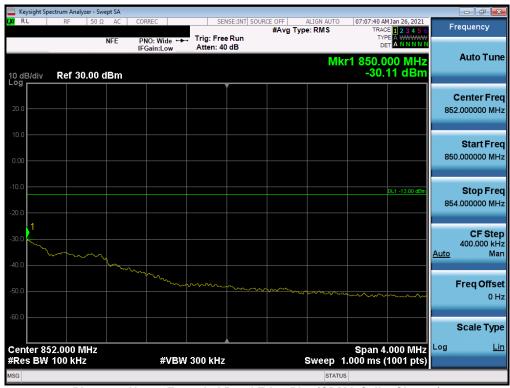
Plot 7-90. Lower Extended Band Edge Plot (CDMA Cell - Ch. 1013)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-91. Upper Band Edge Plot (CDMA Cell - Ch. 777)



Plot 7 86. Upper Extended Band Edge Plot (CDMA Cell - Ch. 777)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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LTE Band 26/5



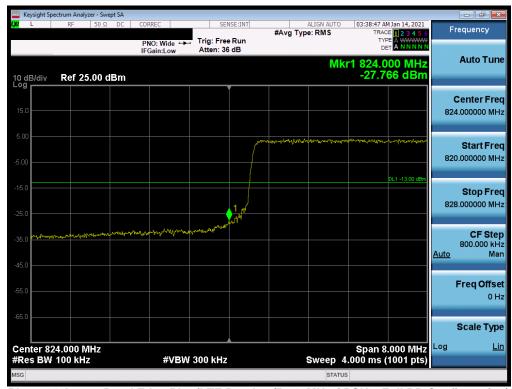
Plot 7-92. Lower Band Edge Plot (LTE Band 26 - 15MHz QPSK - Full RB Configuration)



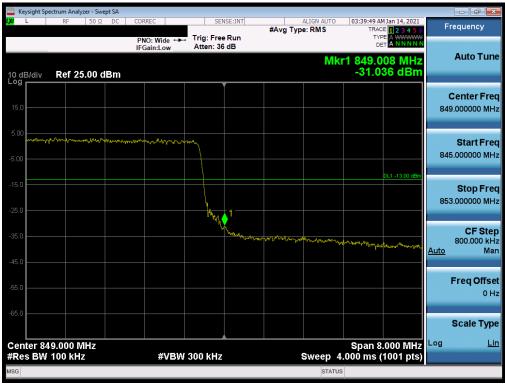
Plot 7-93. Upper Band Edge Plot (LTE Band 26 - 15MHz QPSK - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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Plot 7-94. Lower Band Edge Plot (LTE Band 26/5 - 10MHz QPSK - Full RB Configuration)



Plot 7-95. Upper Band Edge Plot (LTE Band 26/5 - 10MHz QPSK - Full RB Configuration)

FCC ID: A3LSMA426U	Proud to be part of @element	PART 22 MEASUREMENT REPORT	SAMSUNG	Approved by: Technical Manager
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